

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10511734	PROTIC ET AL.
	Examiner	Art Unit
	Lee, Shun	2884

SEARCHED

Class	Subclass	Date	Examiner
250	370.01	6/16/2006	/SL/
250	370.06	6/16/2006	/SL/
250	370.13	6/16/2006	/SL/
Above	UPDATED	3/20/2007	/SL/
Above	UPDATED	10/3/2007	/SL/

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	10/3/2007	/SL/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner